


<b>Search Notes</b>  	<b>Application/Control No.</b>  10551537	<b>Applicant(s)/Patent Under Reexamination</b>  VONDRACEK ET AL.
	<b>Examiner</b>  CHRISTINE CHEN	<b>Art Unit</b>  4116

SEARCHED			
Class	Subclass	Date	Examiner
148	598, 572	12/10/07	CC

SEARCH NOTES		
Search Notes	Date	Examiner
EAST - see search history	12/10/07	CC
Inventor Name Search	12/19/07	CC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner